

**Search Notes**

Application/Control No.

10/525,540

Examiner

Tuyen Q. Tra

Applicant(s)/Patent under  
Reexamination

MAEDA ET AL.

Art Unit

2873

**SEARCHED**

Class	Subclass	Date	Examiner
351	205 206 208 210 212 214 221	3/15/2007	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
TEXT SEARCH ON EAST (USPAT, USPG-PUB, EPO, JPO, DERWENT) INVENTOR SEARCH	3/15/2007	TT